

### IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application of:

Docket No.: 34171

Maurice Lee Smith et al.

Group Art Unit No.: 2171

Serial No.: 10/672,212

Filed: 9/26/03

SYSTEM AND METHOD FOR IDENTIFYING,

REPORTING, AND EVALUATING PRESENCE OF SUBSTANCE

Examiner:

### TRANSMITTAL

Transmitted herewith are: Transmittal; Information Disclosure Statement (1 page); Information Disclosure Statement by Application PTO Form 1449 (2 pages); and return postcard.

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by

Respectfully submitted,

**HOVEY WILLIAMS LLP** 

Dated: April 30, 2004

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Examiner:

Assistant Commissioner of Patents Washington, D.C. 20231

Sir:

### INFORMATION DISCLOSURE STATEMENT

The attached references are being filed to fulfill the duty of candor and good faith toward the Patent and Trademark Office, as required by 37 C.F.R. §1.56.

Any fee which is due in connection with this Statement should be applied against Deposit Account No. 19-0522.

Respectfully submitted,

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FORM PTO-1449 (Boy 2-32)

# U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO. 34171

SERIAL NO. 10/672,212

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use several sheets if necessary)

APPLICANT: Maurice Lee Smith et al.

FILING DATE: 9/26/2003

GROUP: 2171

### **U.S. PATENT DOCUMENTS**

EXAM. INITIAL			DO	CUMI	ENT	NUM	BER		DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
		6	6	2	8	9	4	1	9/30/03	Knoblach et al.			
		6	6	0	8	5	5	9	8/19/03	Lemelson et al.			
		6	5	8	8	7	0	1	7/08/03	Yavnai			
		6	4	9	8	0	4	1	12/24/02	Tabacco et al.			
		6	4	9	0	5	3	0	12/03/02	Wyatt			
		6	4	4	6	0	0	4	9/03/02	Cao et al.			
		6	3	5	6	6	2	5	3/12/02	Castellani et al.			
		6	3	2	7	5	3	5	12/04/01	Evans et al.			
		6	3	1	7	0	8	0	11/13/01	Baxter, Jr.			
		6	1	6	9	4	7	6	01/02/01	Flanagan			
		6	0	8	3	2	4	8	7/04/00	Thompson			
		6	0	7	5	8	9	1	6/13/00	Burman			
		6	0	5	2	1	8	7	4/18/00	Krishnan et al.			
		6	0	2	3	2	2	3	2/08/00	Baxter, Jr.			
		5	9	7	2	6	3	8	10/26/99	Burlage et al.			
		5	9	3	8	7	2	1	8/17/99	Dussell et al.			
		5	8	3	8	2	3	7	11/17/98	Revell et al.			
		5	6	5	0	8	0	0	7/22/97	Benson			
		5	6	4	8	9	1	4	7/15/97	Bauer et al.			
		5	5	2	8	2	4	8	6/18/96	Steiner et al.			
		5	4	7	0	2	3	3	11/28/95	Fruchterman et al.			
		5	4	4	4	4	4	4	8/22/95	Ross			
		4	8	6	1	7	2	7	8/29/89 .	Hauenstein et al.			
				н	1	3	4	4	4/02/94	Baldauf et al.			

### **FOREIGN PATENT DOCUMENTS**

	DOCUMENT NUMBER							DATE	COUNTRY	CLASS	SUBCLASS	TRANSL	ATION
												YES	NO
								<del></del>					

FORM PTO-1449 (Rev. 2-32)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. 33063	SERIAL NO. 10/672,211		
	MATION DISCLOSURE MENT BY APPLICANT	APPLICANT: Maurice Lee Smith et al.			
(Use sev	eral sheets if necessary)	FILING DATE: 9/26/2003	GROUP: 2878		

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

	"Oak Ridge claims sensitivity record for Si MEMS sensor"; June 23, 2003 article in Electronic Engineering Times; Author R. Colin Johnson, page 49.
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.